

Notice of References Cited

Application/Control No.

09/785,969

Applicant(s)/Patent Under
Reexamination
MEYER ET AL.

Examiner

Ronald Laneau

Art Unit

3714

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,154,630	12-2006	Nimura et al.	358/1.18
*	B	US-6,956,666	10-2005	Tanaka, Masahide	358/1.15
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
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	S					
	T					

NON-PATENT DOCUMENTS

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